(Jegal Instruments Examiner) (Date)	NONE (Assistant Examiner) (Date)		511	524 817 819	CROSS REFERENCE(S) CLASS SUBCLASS (ONE SUBCLASS PER BLOCK)	427 391	CLASS	ORIGINAL	Issue Classification				
Tae H. Yoon (Primary Examiner)	·			824	CLASS PER	E(S)				Yoon, Tae H	Examiner	10030988	Application
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